

Activity classification for real-time wearable systems : effect of window length, sampling frequency and number of features on classifier performance

Allik, Ardo; Pilt, Kristjan; Karai, Deniss; Fridolin, Ivo; Leier, Mairo; Jervan, Gert 2016 IEEE EMBS Conference on Biomedical Engineering and Sciences (IECBES) : Kuala Lumpur, 4-8 December 2016 / p. 460-464 : ill
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Advancing novel physical fatigue assessment and human activity monitoring methods towards personalized feedback with wearable sensors = Kantavatel seadmetel põhinevate füüsilise väsimuse hindamise ning inimese aktiivsuse monitoorimise meetodite arendamine personaalseks tagasisideks

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Ellervee, Peeter; Jervan, Gert 2010

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Automated minimization of concurrent online checkers for network-on-chips

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Contention aware scheduling for NoC-based real-time systems

Tagel, Mihkel; **Ellervee, Peeter**; **Hollstein, Thomas**; **Jervan, Gert** Info- ja kommunikatsioonitehnoloogia doktorikooli IKTDK viienda aastakonverentsi artiklite kogumik : 25.-26. novembril 2011, Nelijärve 2011 / p. 75-78 : ill

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